CLAIMS

What is claimed is:

1	1. A method of simultaneously optimizing performance characteristics in
2	circuit synthesis, comprising the steps of:
3	(a) generating a set of circuit parameters for each performance
4	characteristic of a circuit;
5	(b) simultaneously passing each said set of circuit parameters
6	through a respective circuit model; and
7	(c) running a simulation of each said circuit model on an analysis
8	test bench in order to measure performance of said circuit
9	model using said set of circuit parameters, each said analysis
10	test bench adapted to model circuitry external to said circuit
11	and control the type of analysis to be performed for each said
12	performance characteristic of said circuit.
1	2. A method according to claim 1, further comprising the step of receiving
2	the measurements of performance for each simulation in an
3	optimizer, said optimizer adapted to determine whether
4	specifications were met for said simulation.
1	3. A method according to claim 2, further comprising the step of generating
2	new set of circuit parameter values in said optimizer.

- 4. A method according to claim 3, further comprising the step of passing
 said new set of circuit parameter values through the respective said
 circuit model.
- 5. A method according to claim 1, further comprising the step of assigning
 each said analysis to a separate processor for parallel processing.
- 6. A method according to claim 1, further comprising the step of checking a lookup database for previously optimized performance characteristics.
- 7. A method according to claim 1, further comprising the step of saving
 optimized performance characteristics to a lookup database.
- 8. A method according to claim 1, further comprising the step of setting up
 ranges for each said analysis test bench and providing design
 parameters using a simulation script.
- 9. A method according to claim 1, further comprising the step of mapping
 the function of a design parameter to a performance characteristic.
- 10. A simulation system for simultaneously optimizing performance
 characteristics in circuit synthesis, comprising:

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- 3 (a) a set of design parameters for a circuit;
- 4 (b) at least one circuit model for incorporating said set of design
 5 parameters, each said circuit model adapted to model a
 6 portion of said circuit pertaining to a performance
 7 characteristic; and
 - (c) at least one analysis test bench connected to each said circuit model, each said analysis test bench adapted to model circuitry external to said circuit and control the type of analysis to be performed for each said performance characteristic of said circuit.
 - 11. A simulation system according to claim 10 additionally comprising an optimizer adapted to collect the results of said analysis of each said analysis test bench and compare said results to optimal performance specifications for said circuit.
- 12. A simulation system according to claim 11, wherein said optimizer
 comprises an optimization algorithm.
 - 13. A simulation system according to claim 12, wherein said optimization algorithm is adapted to generate parameter values to be passed to each said analysis test bench.

- 14. A simulation system according to claim 10, further comprising a
 simulator for each said analysis test bench.
- 1 15. A simulation system according to claim 10, wherein each said analysis
 2 test bench is adapted to run multiple occurrences of said analysis for
 3 each said circuit.
- 16. A simulation system according to claim 10, wherein said analysis may
 be performed over multiple operating conditions.
- 1 17. A simulation system according to claim 16, wherein said multiple operating conditions are selected from the group consisting of temperature, supply voltage, and fabrication process.
- 1 18. A simulation system according to claim 10, wherein said circuitry is 2 selected from the group consisting of stimuli, power supplies, and 3 load devices.
- 19. A simulation system according to claim 10, further comprising a
 processor for each said circuit model.
- 20. A simulation system according to claim 10, further comprising at least
 one simulation script for each said circuit model.

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- 21. A simulation system according to claim 10, further comprising a
 synthesis plan adapted to set out rules for said analysis.
- 22. A simulation system according to claim 10, further comprising a lookup
 database.
- 23. A simulation system according to claim 22, wherein said lookup database includes a set of performance specifications for each said circuit model.
 - 24. A simulation system according to claim 10, wherein said design parameters are selected from the group consisting of transistor dimensions, bias current values, and adjustable circuit parameters.